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## Temperature-dependent Spectral Emission of Hexagonal Boron Nitride Quantum Emitters on Conductive and Dielectric Substrates

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Title:

**Temperature-dependent spectral emission of hexagonal boron nitride quantum emitters on conductive and dielectric substrates**

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Abstract:

We report a reduction in the linewidth and suppression of spectral diffusion of quantum emitters in hBN supported on a conductive substrate. We observe a temperature-dependent reduction in the spectral emission linewidth for chemical vapor deposition (CVD)-grown, and exfoliated crystals on conductive indium tin oxide (ITO) relative to those seen on silicon dioxide (SiO<sub>2</sub>) substrates. We show that the inhomogeneous linewidth can be suppressed by 45% as a result of using a conductive substrate. We investigate the zero-phonon line profile at temperatures ranging from 4 K to 300 K and decompose the effects of thermal broadening and spectral diffusion at each temperature by Voigt fitting. The temperature dependence of homogeneous and inhomogeneous components of the broadening is discussed.

## I. Introduction

Single photon emitters are essential building blocks of future quantum information technologies [1]. Many different single photon sources have been proposed, including solid-state lattice hosts such as epitaxially grown quantum dots [2] and atomic defects in diamond [3]. Each emitter type is characterized by spectral diffusion, i.e., temporal variations in emission energy around a nominal value, which poses a challenge to the use of solid-state quantum emitters as sources of indistinguishable single photons [4,5]. Single photon emitters in two-dimensional Van der Waals materials have garnered considerable attention due to their promising photophysical properties and the possibility for on-chip integration [6,7]. Among them, color centers in two-dimensional dielectric hexagonal boron nitride (hBN) promise a robust medium for the generation of quantum light with potential for room temperature operation [8–10]. These color centers exhibit a Debye-Waller factor [11]  $> 80\%$ , a brightness on par with the brightest sources of single photons [6,9,12], and linearly polarized emission [11,13], all at room temperature. These unique properties have the potential for quantum communication applications such as quantum key distribution in which a bright source of linearly polarized single photons is required [14,15].

Despite these inherent benefits, several challenges facing hBN color centers need to be resolved to make them suitable for quantum information and sensing applications. The atomic structure of the defects underlying the color centers is under debate [16–21]. As a result, the electronic and spin [22,23] characteristics of these emitters are still not clear, and methods to deterministically create emitters in hBN crystals are not well developed [24–26]. Furthermore, instabilities, such as blinking [12,27,28], bleaching [29], and spectral diffusion, [22,29–31] can yield interesting physical insights but ultimately represent significant practical drawbacks for the use of hBN color centers as a source of indistinguishable single photons. Recently, Fourier transform-limited spectral linewidths have been reported for hBN emitters at both 4 K and 300 K [32,33]. This observation of Fourier transform-limited linewidth has a spectral diffusion-limited time window of 30 ms, inhibiting indistinguishability of the spectral line in consecutive measurements.

Spectral diffusion is the temporal change in energy of emitted photons due to a change in the local electric field distribution of the emitter. This temporal change in energy manifests itself as a series of jumps of the zero phonon line (ZPL) in measurements with time resolution high enough to capture microseconds to milliseconds scale changes in the energy. In lower time resolution measurements, where the acquisition time is longer than the time between spectral jumps, it can be observed as a broadening of the spectral lines [5,34]. The change in the local electric field is thought to be due to either trapping and de-trapping of charge close to the position of the active photon emitter or due to charges hopping from one site to another in the host lattice. The timescale of these spectral jumps in hBN is on the order of microseconds to milliseconds [33,34]. Thermally grown silicon dioxide ( $\text{SiO}_2$ ) on silicon, the material widely used as a substrate for graphene and other two dimensional materials [35,36] due to its low surface roughness, is an insulator prone to charge traps, a source of spectral diffusion for color center emitters. It was reported that fluctuating charge environment can affect spectral diffusion, photon statistics purity, and decay lifetime of excitonic single photon emitters such as emitters in monolayer  $\text{WSe}_2$  and CdSe quantum dots [37–39]. Although another study have noted the effect of substrate choice on emission in hBN [22], the role of the substrate in determining the spectral linewidth has not been addressed.

In this article, we report reduced linewidth and spectral diffusion when conductive transparent material indium tin oxide (ITO) is used as a substrate for hBN color centers. As shown in Fig. 1, a transparent conductive material such as ITO lacks charge traps on its surface and can provide a conductive pathway for charges trapped in hBN to be removed. These removed charges can then screen trapped and mobile charges from the hBN color centers, thereby suppressing spectral diffusion. Unlike many other conventional metals, ITO is transparent in the visible wavelength range and has a positive real part of its dielectric permittivity. As a consequence, it does not quench luminescence emission in proximity to an emitter. Spectral diffusion represents an obstacle to the achievement of stable sources of indistinguishable photons. Thus developing methods to suppress spectral diffusion and increase the coherence time [34] for hBN single photon emitters is an important step towards the use of color centers as sources of indistinguishable photons in quantum applications based on single or entangled photons [14,40].

## II. Results and discussion

### A. Temperature dependence of ZPL in bulk hBN

We start our analysis by investigating color centers in bulk hBN. These centers reflect the intrinsic properties of hBN emitters as they are inside the hBN crystal and isolated from the environment. To fabricate bulk hBN samples, we mechanically cleaved a thick flake from an hBN crystal. AFM measurements showed a thickness of 839nm (See Supplemental Material [41] Fig. S-1). Emitters were initially characterized in a homebuilt confocal microscope at room temperature and then transferred to a variable temperature microscope employing a closed-cycle helium cryostat to perform temperature-dependent emission measurements from 4 K to 300 K. (See Supplemental Material [41] for a complete description of the sample preparation method and experimental setup). We used a 532 nm continuous wave laser to excite the emitters and the photoluminescence (PL) was collected by a microscope objective through a tunable bandpass filter and coupled to either a spectrometer or a Hanbury-Brown-Twiss interferometer to perform an intensity autocorrelation measurement. To locate and observe emitters in bulk hBN, a photoluminescence map of the sample was acquired (See Fig. 2). The spectral and spatial features of 12 selected emitters were identified. For the rest of the discussion, we focus on two representative emitters from this group.

Photoluminescence spectroscopy and intensity correlation measurements ( $g^{(2)}$ ) of these two emitters are shown in Fig. 2. No background subtraction was performed on  $g^{(2)}$  data and the measurements were fitted by a double exponential model function:

$$g^2(\tau) = 1 - b[(1 + a)e^{-\frac{|\tau|}{T_1}} - ae^{-\frac{|\tau|}{T_2}}] \quad (1)$$

Both photon flux statistics show a  $g^2(0)$  dip with values of 0.20 and 0.28, confirming that both emitters are single photon emitters. They exhibit similar decay lifetimes ( $T_1 \approx 1.3$ ns) but their bunching time scales ( $T_2$ ) are different (See Supplemental Material [41] Fig. S-5). A similar decay lifetime suggests that these emitters in principle should exhibit similar Fourier transform-limited linewidth if no extrinsic broadening mechanism is operative. The difference in the bunching shoulder can be explained by the difference in the blinking characteristics of these emitters. [42] More importantly, we noticed that despite a nearly two-fold difference in the linewidth between these emitters both at room temperature and 4 K, the lineshapes of both emitters are similar throughout; namely, both emitters exhibit a Lorentzian lineshape at 300 K and a Gaussian lineshape at 4 K as shown in Fig. 2.

To further investigate the effect of temperature, the ZPL was studied at 4 K, 10 K, 20 K, 40 K, 80 K, 160 K, and 300 K and the results are illustrated in Fig. 3. The evolution of the spectral line position and shape as a function of temperature is shown in Fig. 3-a and 3-b for the two emitters. The linewidths for both emitters remain largely independent of temperature up to the transition temperature ( $T_{tr}$ ) at 40 K and increase significantly at temperatures above  $T_{tr}$  (see Fig. 3-c). These observations also confirm two different modes of broadening for emitters in bulk hBN: a temperature-independent broadening mechanism at  $T < T_{tr}$  and a temperature-dependent broadening at  $T > T_{tr}$ . Similar behavior has been observed in other quantum emitters and is attributed to spectral diffusion and thermal phonon interactions respectively [5,34]. As an inhomogeneous broadening mechanism, spectral diffusion results in Gaussian lineshapes [5]. In contrast, thermal phonon broadening is a result of quadratic interaction between thermal acoustic phonons and the emitter and will result in a homogeneous broadening and a Lorentzian line profile [5,43]. As the temperature increases, the line profile also becomes less Gaussian and more Lorentzian. To analyze the line profile, we fit a convolution of Gaussian and Lorentzian line-shapes to the line profile, also known as a Voigt profile:

$$I_V(\omega) = \frac{A \operatorname{Re}[w(z)]}{\sigma\sqrt{2\pi}} \quad , \quad (2)$$

$$w(z) = e^{-z^2} \operatorname{erfc}(-iz) \quad , \quad z = \frac{\omega - \omega_0 + i\gamma}{\sigma\sqrt{2}} \quad (3)$$

Where  $A$  is amplitude and  $FWHM_{Gaussian} = 2\sigma\sqrt{2 \ln(2)}$  and  $FWHM_{Lorentzian} = 2\gamma$ . [34]

By fitting a Voigt profile to the measured spectral lines, we can measure the FWHM of each Gaussian and Lorentzian component of the line profile at each temperature and deduce the homogeneous and inhomogeneous FWHM. As

shown in the inset of Fig. 3-e the inhomogeneous broadening is independent of temperature up to  $T_{tr}$  for both emitters. At temperatures above  $T_{tr}$ , the Voigt fit does not show any significant Gaussian component and is predominantly Lorentzian. Therefore, for all temperatures above  $T_{tr}$ , we set the value of the Gaussian FWHM to the measured average value of the inhomogeneous linewidth below  $T_{tr}$ , and use a Voigt profile fit to find the Lorentzian FWHM component [5,34]. At  $T_{tr}=40$  K, the Gaussian (inhomogeneous) and Lorentzian (homogeneous) line profiles are almost equal for each emitter. We can also observe two separate peaks for emitter 1. We attribute the weaker peak to spectral jumps at timescales shorter than the one minute exposure time of our spectral measurement, as the intensity of the second peak relative to the first peak varies significantly in time for time scales above one minute (see Supplemental Material [41] Fig. S-6).

In Fig. 3-d the homogeneous linewidth is plotted as a function of temperature in a log-log plot. The results for both emitters can be fitted by a line that corresponds to a power-law dependence of linewidth on the temperature, where the power is the slope of the fit line. We observe here a nearly linear dependence of the linewidth on temperature for both emitter 1 and emitter 2. This observation contrasts with other studies for hBN and diamond quantum emitters which observe a power-law dependence of the third power form [5,34,44,45]. We speculate that this difference in observed power-law temperature dependence may be the result of different structural and electronic configurations of the emitter color centers, a consequence of the diversity of defects seen in hBN [33,46]. A similar linear dependence of linewidth on temperature is observed for excitons in 2D transition metal dichalcogenides [47–49]. Using a similar approach to model hBN, the total linewidth  $\gamma_{total}$  of the ZPL can be written as the sum of an inhomogeneous and homogeneous contributions:

$$\gamma_{total} = \gamma_{inhom.} + \frac{b}{\exp\left(\frac{\theta}{kT}\right) - 1} \quad (4)$$

$$\approx \gamma_{inhom.} + \frac{kb}{\theta} T \quad (5)$$

where ‘ $\theta$ ’ is the acoustic phonon energy and ‘ $b$ ’ is a constant factor. In a regime where the phonon energy is small compared to  $kT$ , a linear dependence of linewidth on temperature can be expected. A recent study [50] on exciton-phonon interaction in hBN shows a similar linear trend in the exciton-phonon scattering rate in hBN.

We also investigated the low-frequency spectral diffusion characteristics of these two emitters (See Supplemental Material [41] Fig. S-6). Emitter 1, which has a broader linewidth, exhibits larger spectral instability. Emitter 2, which has a narrower linewidth, exhibits fewer spectral jumps per unit of time, as can be seen from the Fourier transform of the time evolution trace of the peak position of the emitter’s ZPL. We confirmed this result for the other 10 emitters (See Supplemental Material [41] Fig. S-7) and reveal a correlation between the inhomogeneous linewidth and the average of the Fourier transform of the measured spectral diffusion. This observation also suggests that the origin of inhomogeneous broadening in our measurements is most likely spectral diffusion.

Since inhomogeneous broadening is the limiting factor to reach Fourier transform-limited linewidths at cryogenic temperature in hBN emitters, we also performed a statistical analysis of the inhomogeneous broadening (see Fig. 4-a, b). For the bulk hBN sample, we see that the minimum inhomogeneous FWHM is 0.21 meV (while the spectral resolution limit for our apparatus is 0.03 meV) and the median value is 0.41 meV.

## B. Low temperature broadening and the substrate effects

Bulk hBN has been shown to have stable emitters with relatively narrow linewidths. However, to explore the full potential of the two-dimensional nature of hBN, and to form layered heterostructures, emitters in samples with thicknesses of a few-layer are of considerable interest. A drawback of emitters hosted in a few-layer hBN samples is susceptibility to the environment. This environmental effect can manifest itself as increased spectral diffusion and a decreased coherence time. Therefore, our investigation focused on hBN layers less than 10 nm thick. Chemical vapor deposition (CVD) is a widely employed method to grow thin films of hBN and provides the ability to grow hBN with an arbitrary number of layers on a scale of millimeters to centimeters. Another method for synthesis of few-layer hBN crystal is by mechanical exfoliation, but this method does not provide large films of hBN and lacks precise control

over the thickness of the exfoliated flakes and trial and error is used to achieve the desired thickness. Nonetheless, this method can result in two-dimensional flakes with larger grain sizes.

To test the effect of measurement environment and hBN crystal morphology on inhomogeneous broadening we transferred 5 nm thick CVD-grown hBN films from the copper growth substrate onto SiO<sub>2</sub> and ITO substrates using wet transfer techniques (for details about the growth method, see [51] and Supplemental Material [41]). We also exfoliated a 5 nm thick hBN onto SiO<sub>2</sub> substrate and an 8 nm thick hBN onto the ITO substrate. We observed that for CVD-grown hBN, linewidths at 4 K are almost one order of magnitude larger than those observed in the exfoliated samples with the same thickness and two orders of magnitude larger than emitters in bulk hBN (see Fig. 4). We attribute this difference in linewidth to smaller grain sizes in the CVD films, which are expected to have a larger charge trap density than hBN bulk crystals. Comparing different substrates, for CVD hBN-atop-ITO samples, we observed a 27% reduction of the inhomogeneous FWHM compared to CVD hBN-atop-SiO<sub>2</sub>, (from 37.3meV to 27.7meV). For exfoliated hBN-atop-ITO samples, we observed a 45% reduction of inhomogeneous FWHM compared to exfoliated hBN-atop-SiO<sub>2</sub>, (from 3.1meV to 1.7meV). This observation confirms our hypothesis that using a conductive substrate suppresses spectral diffusion, which is attributed to conductive pathways for transport of charge away from the vicinity of the emitter, as depicted in Fig. 1. Furthermore, no correlation between inhomogeneous broadening and the position of the ZPL wavelength was observed (see Fig. 4-right panel). This indicates that the inhomogeneous broadening mechanism is independent of defect structure and emission wavelength for exfoliated, CVD, and bulk hBN.

To better understand the effect of ambient temperature, we measured the emitter temperature-dependent linewidth for CVD and few-layer exfoliated hBN on SiO<sub>2</sub> and ITO substrates (see Fig. 5 and Supplemental Material [41] Fig. S-9). Unlike bulk hBN, the transition from spectral diffusion broadened to thermally broadened linewidth in CVD hBN does not happen at  $T_{tr} = 40$  K but at around  $T_{tr} = 160$  K (see solid red and dark blue lines). This is a direct consequence of the larger spectral diffusion observed in CVD hBN. For few-layer exfoliated hBN, we observed a larger change in the FWHM with temperature, and a transition temperature below 40 K, despite a larger inhomogeneous linewidth (yellow and purple curves). We suggest that this may be due to the proximity of emitters to the hBN flake surface, and acoustic coupling to the substrate.

### III. Conclusions

In summary, we have studied the photodynamics of hBN single photon emitters in a diverse array of sample environments. We find both a temperature dependent and temperature independent regime for emitter linewidth that we attribute to thermally generated phonon interactions and spectral diffusion, respectively, as two mechanisms responsible for ZPL emission broadening. We suggest that among these two regimes, the spectral diffusion-limited linewidth is dominant at cryogenic temperatures and is independent of temperature, while thermal phonon interaction is dominant at temperatures close to room temperature and increases with a power-law dependence on temperature, with power close to unity. Importantly, we find that the sample morphology and thickness, in the various configurations we investigated, affects the inhomogeneous linewidth, suggesting that the linewidth depends on both the local structure of hBN and the surrounding environment in the crystal. In particular, we show that increasing the carrier density in the local environment of the emitter, achieved using a conductive substrate, significantly reduces the inhomogeneous linewidth. This is of interest for all applications that aim for spectral stability of color center based single photon sources.

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Figures:

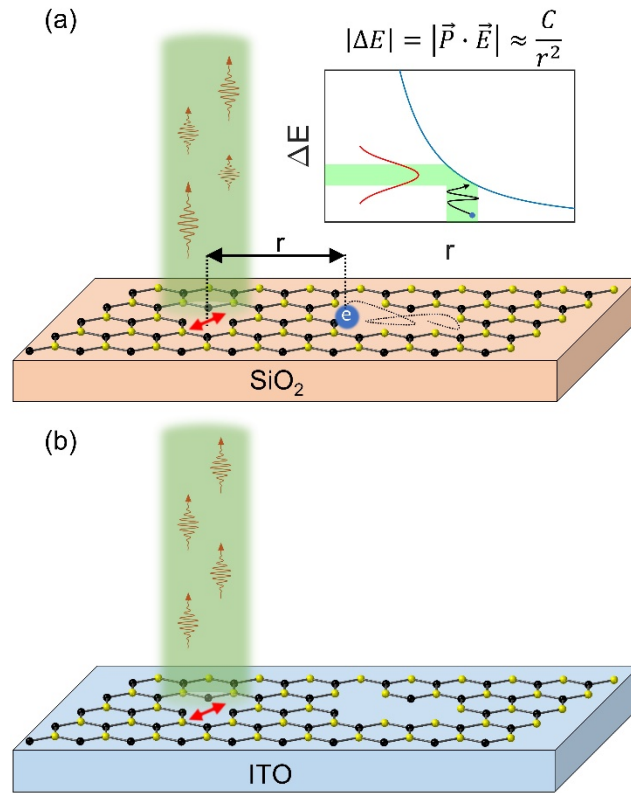


Figure 1. Schematic of substrate effect on spectral diffusion of single photon emitters in hBN. (a) hBN emitter on an insulating SiO<sub>2</sub> substrate is prone to larger spectral diffusion due to charge traps in hBN, SiO<sub>2</sub>, and their interface. The inset shows Stark shift dependence on distance of nearby charges and how changes in the local charge distribution can broaden the linewidth. (b) hBN emitter on an ITO substrate shows narrower linewidth as a result of fewer charge traps in hBN, ITO, and their interface.

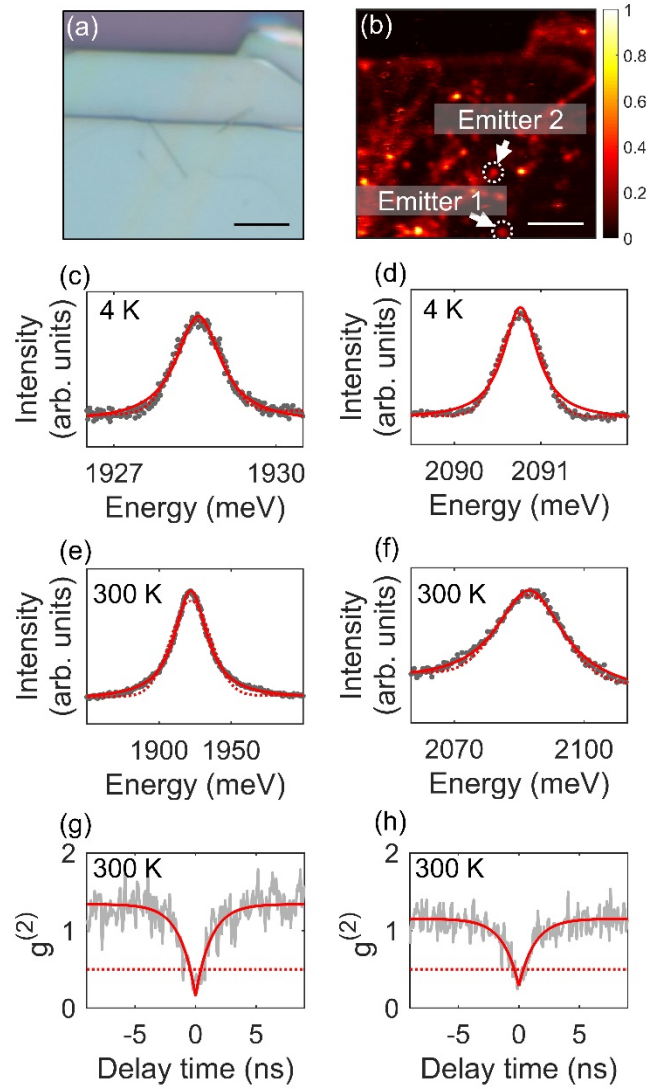


Figure 2. Quantum emitters in bulk hBN. (a) Microscope image and (b) photoluminescence map of a bulk hBN crystal. The arrows show the position of two emitters under study; scale bar corresponds to 5  $\mu\text{m}$ . (c) 4 K and (e) 300 K spectra of ZPL of emitter 1. Solid line shows Lorentzian and the dashed line shows Gaussian fits (g) shows photon anti-bunching for emitter 1. (d), (f), and (h) show the same plots for emitter 2.

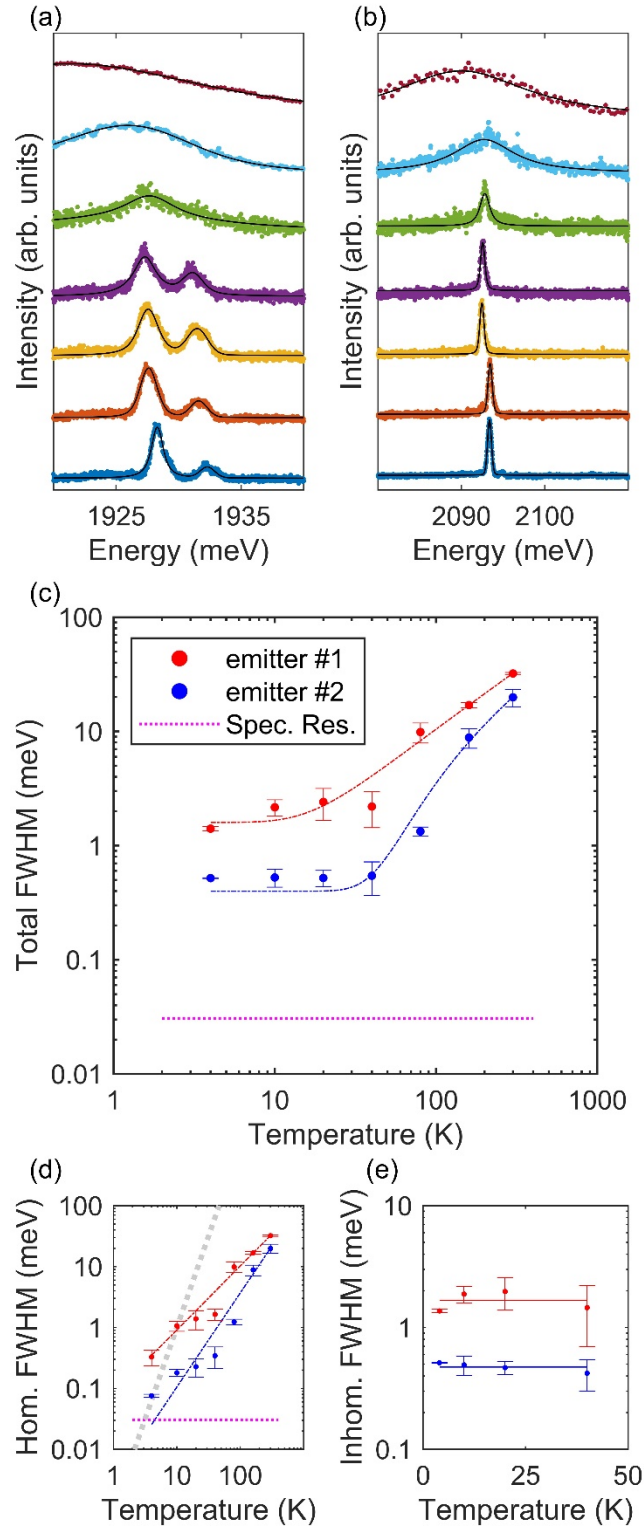


Figure 3. Temperature dependence of ZPL for emitters in bulk hBN. Effect of temperature on lineshape for emitter 1 (a) and emitter 2 (b) from 4 K to 300 K. (c) Linewidth against temperature for two emitters under study. Linear fits for temperatures below and above 40 K are shown; dashed lines are fits with a model equation (4), and the dashed magenta line shows the spectral resolution of the spectrometer used in this study. In (d) and (e) homogeneous and inhomogeneous components of linewidth extracted by Voigt fit are plotted as a function of temperature. The slope of

power-law fit for homogeneous linewidth for emitter 1 is  $1.05 \pm 0.21$  and for emitter 2 is  $1.54 \pm 0.38$ . The dotted grey line in (d) corresponds to  $T^3$  dependence of linewidth on temperature.

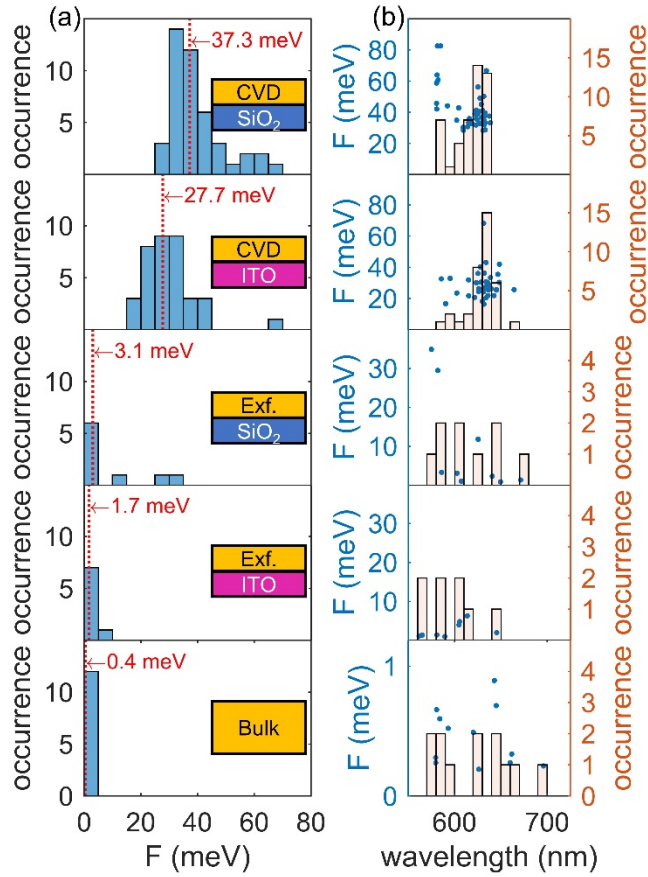


Figure 4. Effect of hBN crystal and substrate type on inhomogeneous broadening. Panel (a) is a histogram of linewidths for emitters and panel (b) is the scatter plot of linewidth against the ZPL wavelength and histogram of the number of occurrences of a ZPL wavelength, from top to bottom this figure shows the result for CVD film on SiO<sub>2</sub> substrate, CVD film on ITO substrate, exfoliated flake on SiO<sub>2</sub> substrate, exfoliated flake on ITO substrate, and bulk hBN crystal respectively. The red dashed line shows the median of inhomogeneous linewidth for each sample.



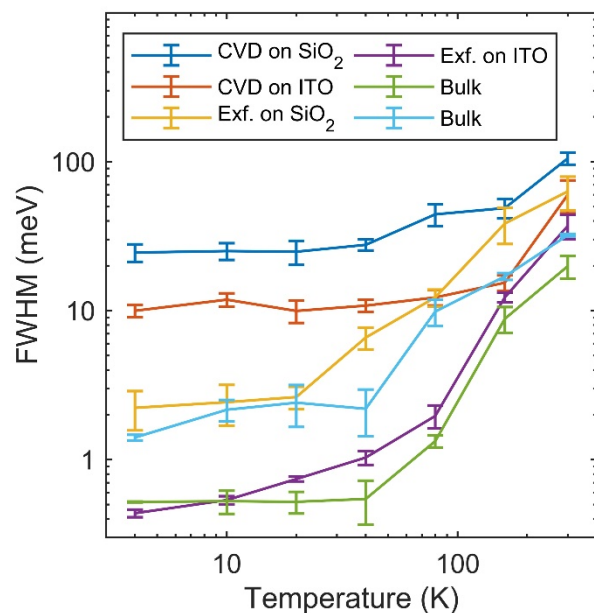


Figure 5. Temperature dependence of ZPL FWHM for various emitters in bulk hBN, 5 nm thick exfoliated hBN on SiO<sub>2</sub>, 8 nm thick exfoliated hBN on ITO, 5 nm thick CVD hBN on SiO<sub>2</sub>, and 5 nm thick CVD hBN on ITO. The result illustrates the total FWHM for temperatures from 4 K to 300 K.